# onsemi

## <u>Silicon Carbide (SiC)</u> <u>MOSFET</u> – 44 mohm, 650 V, M2, TO-247-4L

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
650 V	70 mΩ @ 18 V	47 A

## NTH4L060N065SC1

#### Features

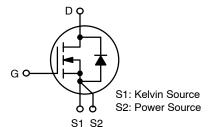
- Typ.  $R_{DS(on)} = 44 \text{ m}\Omega @ V_{GS} = 18 \text{ V}$ Typ.  $R_{DS(on)} = 60 \text{ m}\Omega @ V_{GS} = 15 \text{ V}$
- Ultra Low Gate Charge ( $Q_{G(tot)} = 74 \text{ nC}$ )
- Low Capacitance (C<sub>oss</sub> = 133 pF)
- 100% Avalanche Tested
- $T_J = 175^{\circ}C$
- This Device is Halide Free and RoHS Compliant with exemption 7a, Pb–Free 2LI (on second level interconnection)

#### **Typical Applications**

- SMPS (Switching Mode Power Supplies)
- Solar Inverters
- UPS (Uninterruptable Power Supplies)
- Energy Storages

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Param	Symbol	Value	Unit		
Drain-to-Source Voltage			V <sub>DSS</sub>	650	V
Gate-to-Source Voltage	•		V <sub>GS</sub>	-8/+22	V
	Recommended Operation Values T <sub>C</sub> < 175°C of Gate-to-Source Voltage		V <sub>GSop</sub>	-5/+18	V
Continuous Drain Current (Note 1)	Steady T <sub>C</sub> = 25°C State		Ι <sub>D</sub>	47	A
Power Dissipation (Note 1)			PD	176	W
Continuous Drain Current (Note 1)	Steady T <sub>C</sub> = 100°C State		Ι <sub>D</sub>	33	A
Power Dissipation (Note 1)			PD	88	W
Pulsed Drain Current (Note 2)	$T_{\rm C} = 25^{\circ}{\rm C}$		I <sub>DM</sub>	152	A
Operating Junction and S Range	T <sub>J</sub> , T <sub>stg</sub>	–55 to +175	°C		
Source Current (Body Di	ا <sub>S</sub>	35	А		
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L(pk)</sub> = 10.1 A, L = 1 mH) (Note 3)			E <sub>AS</sub>	51	mJ
Maximum Lead Temperature for Soldering (1/8" from case for 5 s)			ΤL	260	°C



N-CHANNEL MOSFET



CASE 340CJ

**MARKING DIAGRAM** 

065SC1 AYWWZZ

H4L060065SC1 = Specific Device Code

A = Assembly Location

- Y = Year
- WW = Work Week
- ZZ = Lot Traceability

#### ORDERING INFORMATION

Device	Package	Shipping
NTH4L060N065SC1	TO247-4L	30 Units / Tube

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

2. Repetitive rating, limited by max junction temperature.

3. EAS of 51 mJ is based on starting  $T_J$  = 25°C; L = 1 mH,  $I_{AS}$  = 10.1 A,  $V_{DD}$  = 50 V,  $V_{GS}$  = 18 V.

#### Table 1. THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Case - Steady State (Note 1)	$R_{\theta JC}$	0.85	°C/W
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	40	

#### Table 2. ELECTRICAL CHARACTERISTICS ( $T_J = 25^{\circ}C$ unless otherwise specified)

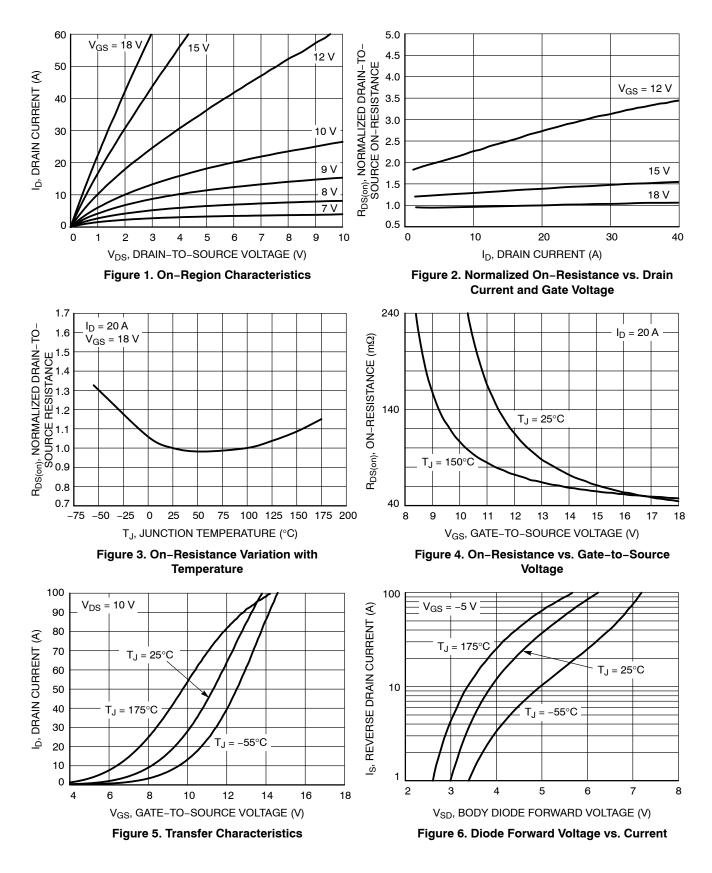
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•	-					
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 1 mA		650	-	-	V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>	$I_D$ = 20 mA, referenced to 25°C		-	0.15	-	V/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	$T_J = 25^{\circ}C$	-	-	10	μA
	$V_{DS} = 650 \text{ V}$ $T_{J} = 175^{\circ}\text{C}$	T <sub>J</sub> = 175°C	-	-	1	mA	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{GS} = +18/-5 \text{ V}, \text{ V}_{DS}$	= 0 V	-	-	250	nA
ON CHARACTERISTICS (Note 2)		•					
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{D} = 6.5 \text{ m}$	A	1.8	2.8	4.3	V
Recommended Gate Voltage	V <sub>GOP</sub>			-5	-	+18	V
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 15 V, I <sub>D</sub> = 20 A	, T <sub>J</sub> = 25°C	-	60	-	mΩ
		V <sub>GS</sub> = 18 V, I <sub>D</sub> = 20 A	, T <sub>J</sub> = 25°C	-	44	70	
		V <sub>GS</sub> = 18 V, I <sub>D</sub> = 20 A	, T <sub>J</sub> = 175°C	-	50	-	
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 20 A		-	12	-	S
CHARGES, CAPACITANCES & GATE RES	ISTANCE						
Input Capacitance	C <sub>ISS</sub>	$V_{GS}$ = 0 V, f = 1 MHz, $V_{DS}$ = 325 V		-	1473	-	pF
Output Capacitance	C <sub>OSS</sub>			-	133	_	
Reverse Transfer Capacitance	C <sub>RSS</sub>			-	13	-	
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS} = -5/18 \text{ V}, V_{DS} = 520 \text{ V},$ $I_D = 20 \text{ A}$		-	74	-	nC
Gate-to-Source Charge	Q <sub>GS</sub>			-	20	-	
Gate-to-Drain Charge	Q <sub>GD</sub>			-	23	-	
Gate-Resistance	R <sub>G</sub>	f = 1 MHz		-	3.9	-	Ω
SWITCHING CHARACTERISTICS	•				•		
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS} = -5/18 \text{ V}, \text{ V}_{DS} =$	400 V,	-	11	-	ns
Rise Time	t <sub>r</sub>	$I_D = 20 \text{ A}, R_G = 2.2 \Omega$ Inductive load		-	14	-	
Turn-Off Delay Time	t <sub>d(OFF)</sub>			-	24	-	
Fall Time	t <sub>f</sub>	1		-	11	_	
Turn-On Switching Loss	E <sub>ON</sub>	1		-	45	-	μJ
Turn-Off Switching Loss	E <sub>OFF</sub>	1		-	18	_	1
Total Switching Loss	E <sub>tot</sub>	1	-	63	_		
DRAIN-SOURCE DIODE CHARACTERIST	ICS						
Continuous Drain-Source Diode Forward Current	I <sub>SD</sub>	$V_{GS} = -5 \text{ V}, \text{ T}_{J} = 25^{\circ}\text{C}$ $V_{GS} = -5 \text{ V}, \text{ I}_{SD} = 20 \text{ A}, \text{ T}_{J} = 25^{\circ}\text{C}$		_	-	35	А
Pulsed Drain-Source Diode Forward Current (Note 2)	I <sub>SDM</sub>			_	-	152	
Forward Diode Voltage	V <sub>SD</sub>			-	4.3	_	V

#### Table 2. ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = $25^{\circ}$ C unless otherwise specified) (continued)

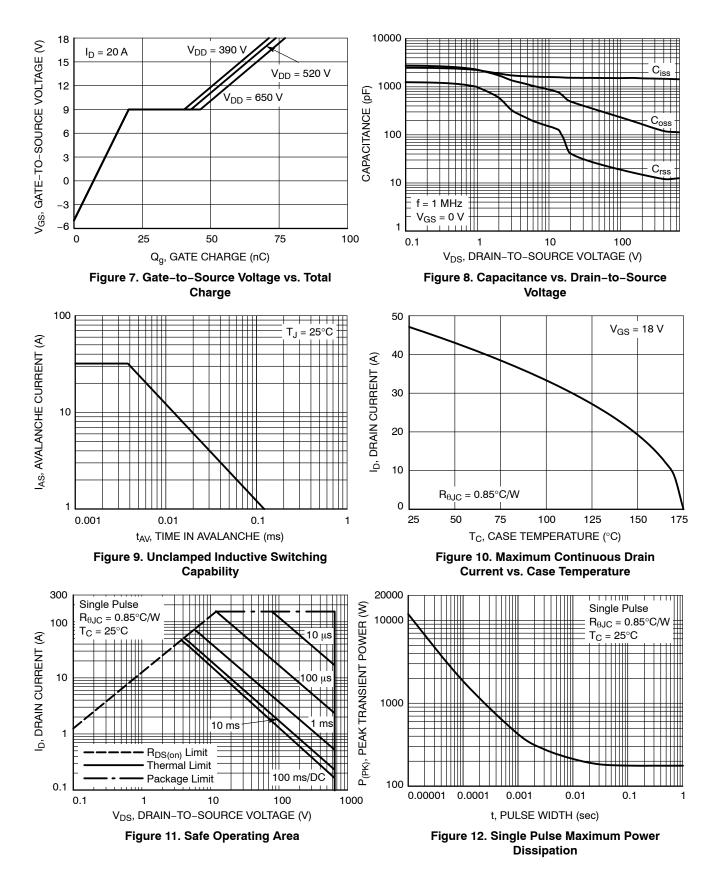
Parameter	Symbol	Test Condition	Min	Тур	Max	Unit		
DRAIN-SOURCE DIODE CHARACTERISTICS								
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = -5/18 V, I <sub>SD</sub> = 20 A, dI <sub>S</sub> /dt = 1000 A/μs	-	17.7	-	ns		
Reverse Recovery Charge	Q <sub>RR</sub>	αι <sub>S</sub> /αt = 1000 Α/μs	-	90.6	-	nC		
Reverse Recovery Energy	E <sub>REC</sub>		-	8.7	-	μJ		
Peak Reverse Recovery Current	I <sub>RRM</sub>		-	10.2	-	А		
Charge Time	Та		-	9.8	-	ns		
Discharge Time	Tb		-	7.8	-	ns		

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

#### **TYPICAL CHARACTERISTICS**



#### TYPICAL CHARACTERISTICS (continued)



#### TYPICAL CHARACTERISTICS (continued)

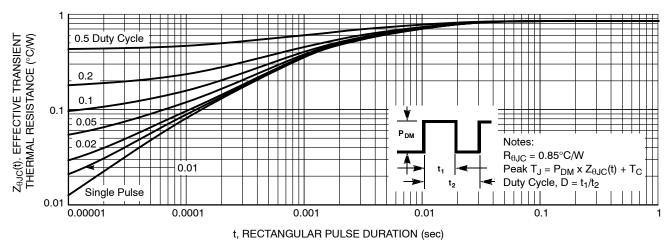
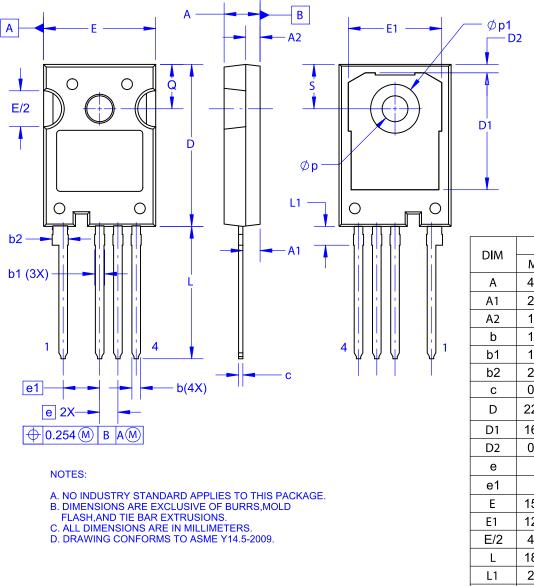


Figure 13. Junction-to-Case Thermal Response



TO-247-4LD CASE 340CJ ISSUE A

DATE 16 SEP 2019



	MILLIMETERS				
DIM	MIN	NOM	MAX		
А	4.80	5.00	5.20		
A1	2.10	2.40	2.70		
A2	1.80	2.00	2.20		
b	1.07	1.20	1.33		
b1	1.20	1.40	1.60		
b2	2.02	2.22	2.42		
С	0.50	0.60	0.70		
D	22.34	22.54	22.74		
D1	16.00	16.25	16.50		
D2	0.97	1.17	1.37		
е	2.54 BSC				
e1	Ę	5.08 BSC	2		
Е	15.40	15.60	15.80		
E1	12.80	13.00	13.20		
E/2	4.80	5.00	5.20		
L	18.22	18.42	18.62		
L1	2.42	2.62	2.82		
р	3.40	3.60	3.80		
p1	6.60	6.80	7.00		
Q	5.97	6.17	6.37		
S	5.97	6.17	6.37		

DOCUMENT NUMBER:	98AON13852G	Electronic versions are uncontrolled except when accessed directly from the Document Repository. Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.				
DESCRIPTION:	TO-247-4LD		PAGE 1 OF 1			
ON Semiconductor and 🕕 are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries.						

ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.

onsemi, ONSEMI, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does **onsemi** assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using **onsemi** products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by **onsemi**. "Typical" parameters which may be provided in **onsemi** data sheets and/or specifications can and do vary in different applications and calcular performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. **onsemi** does not convey any license under any of its intellectual property rights nor the rights of others. **onsemi** products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use **onsemi** products for any such unintended or unauthorized application, Buyer shall indemnify and hold **onsemi** and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that **onsemi** was negligent regarding the design or manufacture of the part. **onsemi** is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

#### PUBLICATION ORDERING INFORMATION

#### LITERATURE FULFILLMENT:

#### TECHNICAL SUPPORT

onsemi Website: www.onsemi.com

Email Requests to: orderlit@onsemi.com

North American Technical Support: Voice Mail: 1 800-282-9855 Toll Free USA/Canada Phone: 011 421 33 790 2910

Europe, Middle East and Africa Technical Support: Phone: 00421 33 790 2910 For additional information, please contact your local Sales Representative

### **X-ON Electronics**

Largest Supplier of Electrical and Electronic Components

Click to view similar products for MOSFET category:

Click to view products by ON Semiconductor manufacturer:

Other Similar products are found below :

614233C 648584F IRFD120 JANTX2N5237 2N7000 FCA20N60\_F109 FDZ595PZ 2SK2545(Q,T) 405094E 423220D MIC4420CM-TR VN1206L 614234A 715780A SSM6J414TU,LF(T 751625C IPS70R2K0CEAKMA1 2SK2614(TE16L1,Q) DMN1017UCP3-7 EFC2J004NUZTDG ECH8691-TL-W FCAB21350L1 P85W28HP2F-7071 DMN1053UCP4-7 NTE2384 NTE2969 NTE6400A IPS60R3K4CEAKMA1 DMN1006UCA6-7 DMN16M9UCA6-7 STF5N65M6 STU5N65M6 C3M0021120D DMN13M9UCA6-7 BSS340NWH6327XTSA1 IPS60R1K0PFD7SAKMA1 IPS60R360PFD7SAKMA1 IPS60R600PFD7SAKMA1 IPS60R210PFD7SAKMA1 DMN2990UFB-7B IPS60R280PFD7SAKMA1 IPD60R280PFD7SAUMA1 IPD60R360PFD7SAUMA1 SSM3K35CT,L3F IPLK60R1K0PFD7ATMA1 NTPF450N80S3Z IPLK60R1K5PFD7ATMA1 IPBE65R190CFD7AATMA1 IPB65R190CFD7AATMA1 2N7002W-G